

N-Channel Enhancement Mode Power MOSFET

GENERAL FEATURES

• $V_{DS} = 60V, I_D = 0.5A$

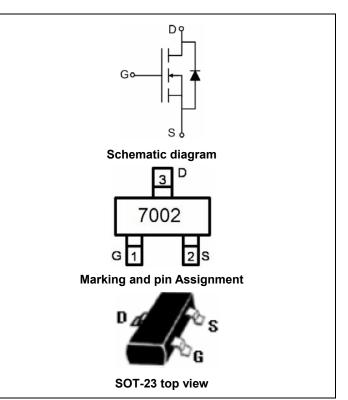
 $R_{DS(ON)} < 3\Omega @ V_{GS} = 5V$

 $R_{DS(ON)} < 2\Omega$ @ V_{GS} =10V

- Lead free product is acquired
- Surface Mount Package

Application

- Direct Logic-Level Interface: TTL/CMOS
- Drivers: Relays, Solenoids, Lamps, Hammers, Display, Memories, Transistors, etc.
- Battery Operated Systems
- Solid-State Relays



Package Marking And Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
7002	HM7002	SOT-23	Ø180mm	8 mm	3000 units

Absolute Maximum Ratings (TA=25℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	60	V
Gate-Source Voltage	V _G s	±20	V
Prain Current Centinuous@ Current Pulsed (Note 1)	I _D	0.5	Α
n Current-Continuous@ Current-Pulsed (Note 1)	I _{DM}	0.8	Α
Maximum Power Dissipation	P _D	0.2	W
Operating Junction and Storage Temperature Range	T_{J} , T_{STG}	-55 To 150	$^{\circ}$ C

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{ heta JA}$	625	°C/W
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Electrical Characteristics (TA=25 ℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	60	68	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =60V,V _{GS} =0V	-	-	1	μA

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Gate-Body Leakage Current	I_{GSS}	V_{GS} =±20 V , V_{DS} =0 V	-	-	±100	nA
On Characteristics (Note 3)			•			
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	1	1.7	2.5	V
Drain-Source On-State Resistance	D	V _{GS} =5V, I _D =0.05A	-	1.3	3	Ω
Didin-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =0.5A	-	1.1	2	Ω
Forward Transconductance	g FS	g _{FS} V _{DS} =10V,I _D =0.2A		-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	\/ =20\/\/ =0\/	-	20	50	PF
Output Capacitance	Coss	V_{DS} =30V, V_{GS} =0V, F=1.0MHz	-	10	20	PF
Reverse Transfer Capacitance	C _{rss}	F=1.0WHZ	-	3.6	5	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	10	-	nS
Turn-on Rise Time	t _r	V_{DD} =30V, I_{D} =0.2A	-	50	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10V, R_{GEN} =10 Ω	-	17	-	nS
Turn-Off Fall Time	t _f		-	10	-	nS
Total Gate Charge	Q_{g}	V _{DS} =10V,I _D =0.5A, V _{GS} =4.5V	-	1.7	3	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =0.5A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	0.5	Α

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- **3.** Pulse Test: Pulse Width ≤ 300μ s, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

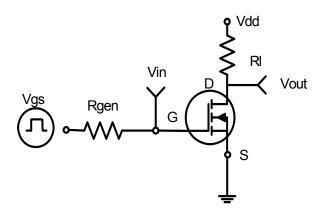


Figure 1:Switching Test Circuit

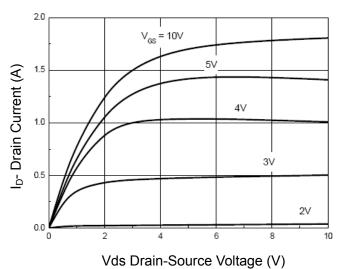


Figure 3 Output CHARACTERISTICS

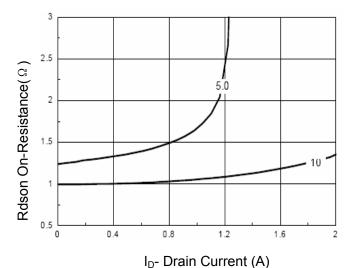


Figure 5 Drain-Source On-Resistance

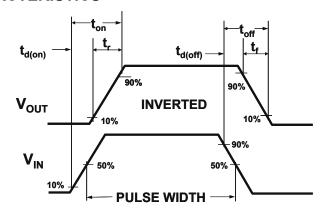


Figure 2:Switching Waveforms

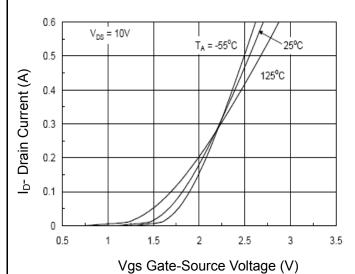
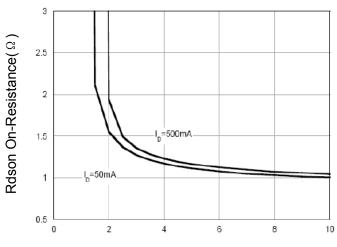


Figure 4 Transfer Characteristics

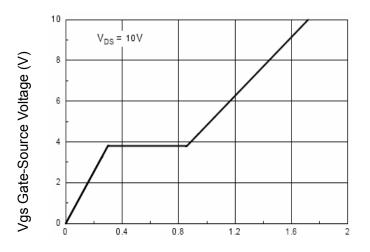


Vgs Gate-Source Voltage (V)

Figure 6 Rdson vs Vgs

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Qg Gate Charge (nC) Figure 7 Gate Charge

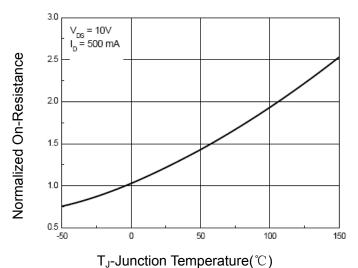


Figure 9 Drain-Source On-Resistance

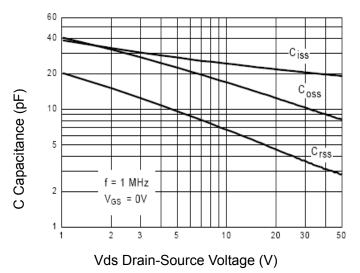
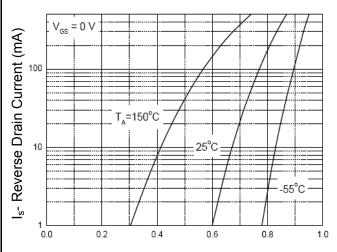


Figure 11 Capacitance vs Vds



Vsd Source-Drain Voltage (V)

Figure 8 Source-DrainDiode Forward

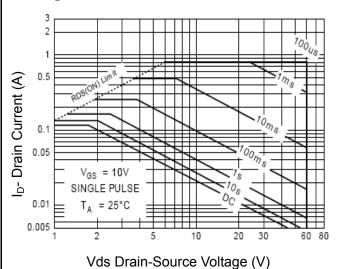


Figure 10 Safe Operation Area

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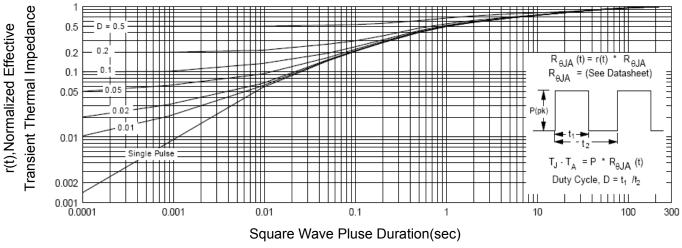
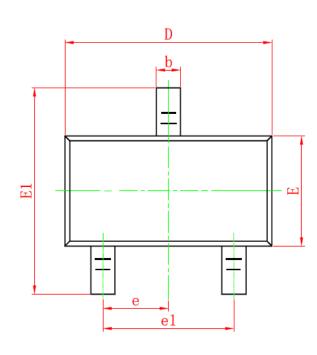
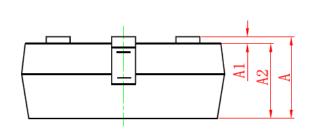


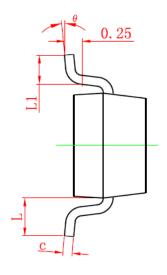
Figure 12 Normalized Maximum Transient Thermal Impedance

SOT-23 PACKAGE INFORMATION









Symbol	Dimensions in Millimeters			
	MIN.	MAX.		
Α	0.900	1.150		
A1	0.000	0.100		
A2	0.900	1.050		
b	0.300	0.500		
С	0.080	0.150		
D	2.800	3.000		
E	1.200	1.400		
E1	2.250	2.550		
е	0.950TYP			
e1	1.800	2.000		
L	0.550REF			
L1	0.300	0.500		
θ	0°	8°		

NOTES

- 1. All dimensions are in millimeters.
- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.
- $5. \ Controlling \ dimension \ is \ millimeter, \ converted \ inch \ dimensions \ are \ not \ necessarily \ exact.$

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